





Bristol Composites Institute

The Use of Polarisation for Hi-Rate Defect Detection

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Presentation outline

- Background
- Motivation
- Project aim
- Why Polarisation?
- Current & Future Plans







Introduction

- **High-rate automated manufacture** is essential to meet the growing demand of the aerospace industry.
- **Autoclave processing** is not cost-effective for scaling production rates.
- **Out-of-autoclave processing** and **large volume deposition** techniques show potential to meet rate requirements.
- **Inspection** and rework often consumes over **50%** of the deposition cycle time [1,2].









 Brasington et al, Automated fiber placement: A review of history, current technologies, and future paths forward, 2021
Maass D, Progress in automated ply inspection of AFP layups, 2015



Introduction









Why Polarisation?

• The optical characteristics of carbon fibre polarise incident light in the fibre direction [1].



Orientation $\approx 135^{\circ}$

Orientation $\approx 45^{\circ}$







 [1] Ernst et al, Measuring a fibre direction of a carbon fibre material and producing an object in a carbon-fibre composite construction WO2014/076128
[2] Atkinson et al, Precision fibre angle inspection for carbon fibre composite structures using polarisation vision.

AoLP



Why Polarisation?



AolP



Laser Scan



Polarisation method is more robust to lighting variance [1].

Polarisation method shows potential to reduce defect detection pre-processing and segmentation.







[1] Atkinson et al, Precision fibre angle inspection for carbon fibre composite structures using polarisation vision.



Polarised imaging for fibre angle detection

• Sensor developments allow the capture of polarised state of light from a single exposure.









Polarised imaging for fibre angle detection

Super

• Sensor developments allow the capture of polarised state of light from a single exposure.

 $I_{\theta} = Intensity at microfilter angle within super pixel unit.$

Stokes Vector =
$$\begin{bmatrix} S_0 \\ S_1 \\ S_2 \end{bmatrix}$$

AOLP $\phi = \frac{1}{2} \arctan_2(S_2, S_1)$

Where;
$$S_0 = \frac{I_0 + I_{45} + I_{90} + I_{135}}{2}$$
, $S_1 = I_0 - I_{90}$, $S_2 = I_{45} - I_{135}$





Characterising defect capability

• What defects are identifiable?



In-Plane Waviness



Out-of-Plane Waviness



FOD











- What defects are identifiable?
- What features can be measured?









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- How do the measured values compare with baseline?









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Long Term Plans

- Optimising process parameters & and setup for maximum defect detection accuracy.
- Evaluating high-speed in-line inspection feasibility for NCF Materials.
- Implementing and experimentally validating polarisation imaging in a highrate material deposition system.







Questions?

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